Applications of High-Resolution MFM System with Low

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Abstract

Magnetic force microscopy (MFM) is very useful for observing magnetic domain structures. However, due to observing magnetic domain structures. However, due to stray fields from a MFM probe, observations of small magnetic domain structures are limited. We have developed a high-resolution MFM system that utilizes a low moment probe and a Q-controlled prove-driver, which allows the sensitive measurement in a vacuum without disturbing domain structures. Using this events disturbing domain structures. Using this system, resolution finer than 20nm was achieved. Here, advantages of this MFM are demonstrated using a honeycomb nano-network, a semicircular loop and a cross-shaped pattern.

4. MFM sensitivity



There is a range of Q-factor with the stable and sensitive.

5. What is Q-control?



6. Comparison of Q-control in Air / in a Vacuum

Changes of Q-curve when approaching the probe close to the sample



Distance dependence with Q-factor



Spring constant 40N/m Low moment probe(t=24nm)

Sample Perpendicular recording medium 200kFCI (Bit length: 127nm)

> Range of stable Q in air 200 Q 2000 in a vacuum

2000 Q 8000

Q-curve and Q-factor in air is influenced by the change of the viscous drag.

This phenomenon isn't desirable in MFM measurement.

> Relation between Q-factor and MFM sensitivity



Q-control in a vacuum is higher sensitivity and wider range of stable Q-factor[1].

1. What is MFM?



2. Unsolved Problems and Solution



Moment Probe and Q-control in a Vacuum



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7. High-Resolution MFM System



Environment Controllable SPM (In air, in a vacuum and in liquid)

P: 10⁻⁵ (Pa) by a turbo molecule pump

T : - 140 ~ + 800 () by LN₂ and a heater

SPI4000/ E-sweep and SPA300HV, SII NanoTechnology Inc.

8. Perpendicular Recording Media^[1]



recording medium τſ ſΠ

Perpendicular

Bit length: 32nm Recording density 800kFCI Sample : Fuii Electric Ltd.& NHK

We have succeeded in the observation of 1200kFCI (bit length: 21nm) now.

9. NiFe Honeycomb Nano-Network^[2]



To investigate frustrated magnetic interaction in small magnets

High-Resolution MFM observations



10. NiFe Semicircular Wire Loop^[3]



High-Resolution MFM observations







Low-moment probe

Q = 6000 in a vacuum

wall

No signal was observed.

11. NiFe Cross-Shaped Pattern



Summary

We have demonstrated the effectiveness of the high-resolution MFM that involves the use of a low moment probe and Q-control system in a vacuum. Standard high moment probe disturbs the domain structure of the sample. In contrast, the low moment probe allows the stable and clear observation of magnetic domain. The high-resolution MFM with low-moment probe and Qcontrol in a vacuum should be powerful for exploring nano-scale magnetism.

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Reference

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